Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/762,170	LEE ET AL.
Examiner	Art Unit
Duc T. Doan	2188

SEARCHED						
Class	Subclass	Date	Examiner			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
East sear	ch attached	8/10/2006	DD		

	STRATEGY	,
	DATE	EXMR
IEEE Explore	8/10/2006	DD
update search; inventor search	8/10/2006	DD